

<b>Notice of References Cited</b>	Application/Control No. 10/507,920	Applicant(s)/Patent Under Reexamination MIHAI ET AL.	
	Examiner David HC NHU	Art Unit 2818	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,518,192 @	02-2003	Khan et al.	438/714
	B	US-6,422,077 B1	07-2002	Krauss et al.	73/514.25
	C	US-5,453,628	09-1995	Hartsell et al.	257/76
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	XP-001153333	3/18-1/202	USA	International Symposium	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	
	V	
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	X	

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